

## **Die Datasheet**

## GB05SHT12-CAL

# High Temperature Silicon Carbide Power Schottky Diode

## $V_{RRM}$ = 1200 V $I_F @ 25 \, ^{\circ}C$ = 8 A $Q_C$ = 17 nC

#### **Features**

- 1200 V Schottky rectifier
- 210 °C maximum operating temperature
- · Zero reverse recovery charge
- · Superior surge current capability
- Positive temperature coefficient of V<sub>F</sub>
- Temperature independent switching behavior
- Lowest figure of merit Q<sub>C</sub>/I<sub>F</sub>
- Available screened to Mil-PRF-19500









Die Size = 1.6 mm x 1.6 mm

#### **Advantages**

- High temperature operation
- Improved circuit efficiency (Lower overall cost)
- · Low switching losses
- Ease of paralleling devices without thermal runaway
- Smaller heat sink requirements
- Industry's lowest reverse recovery charge
- Industry's lowest device capacitance
- Ideal for output switching of power supplies
- Best in class reverse leakage current at operating temperature

#### **Applications**

- Down Hole Oil Drilling
- · Geothermal Instrumentation
- · Solenoid Actuators
- General Purpose High-Temperature Switching
- Amplifiers
- Solar Inverters
- Switched-Mode Power Supply (SMPS)
- Power Factor Correction (PFC)

## Maximum Ratings at T<sub>j</sub> = 210 °C, unless otherwise specified

Parameter	Symbol	Conditions	Values	Unit
Repetitive peak reverse voltage	$V_{RRM}$		1200	V
Continuous forward current	I <sub>F</sub>	$T_C = 25  ^{\circ}C,  R_{thJC} = 3.4$	8	A
Continuous forward current	I <sub>F</sub>	$T_C \le 190 {}^{\circ}\text{C},  R_{thJC} = 3.4$	2.5	Α
RMS forward current	I <sub>F(RMS)</sub>	$T_C \le 190 {}^{\circ}\text{C},  R_{thJC} = 3.4$	4.3	Α
Surge non-repetitive forward current, Half Sine Wave	$I_{F,SM}$	$T_{C}$ = 25 °C, $t_{P}$ = 10 ms	30	А
Non-repetitive peak forward current	$I_{F,max}$	$T_{\rm C}$ = 25 °C, $t_{\rm P}$ = 10 $\mu {\rm s}$	120	Α
l <sup>2</sup> t value	∫i² dt	$T_{\rm C}$ = 25 °C, $t_{\rm P}$ = 10 ms	5	A <sup>2</sup> S
Power dissipation	P <sub>tot</sub>	$T_C = 25  ^{\circ}C,  R_{thJC} = 3.4$	66	W
Operating and storage temperature	$T_j$ , $T_stg$		-55 to 210	°C

#### Electrical Characteristics at T<sub>j</sub> = 210 °C, unless otherwise specified

Parameter	Cumbal	Conditions mi		Values		11:44	
Parameter	Symbol			min.	typ.	max.	Unit
Diode forward voltage	$V_{F}$	. ,	I <sub>F</sub> = 2.5 A, T <sub>j</sub> = 25 °C		1.6		V
Diode forward voltage	VF	I <sub>F</sub> = 2.5 A, T <sub>j</sub> = 210 °C			2.8		
Reverse current	ı	V <sub>R</sub> = 1200 V, T <sub>i</sub> = 25 °C		1	10	μΑ	
Reverse current	I <sub>R</sub>	V <sub>R</sub> = 1200 V, T <sub>i</sub> = 210 °C		25	200		
Total canacitive charge	Qc	V <sub>R</sub> = 400			17		nC
Total capacitive charge		$I_F \le I_{F,MAX}$	V <sub>R</sub> = 960 V		29		nc
Switching time	t <sub>s</sub>	dI <sub>F</sub> /dt = 200 A/μs Τ <sub>i</sub> = 210 °C	V <sub>R</sub> = 400 V		< 25	no	
		V <sub>R</sub> = 960 V		\ 25		ns	
		$V_R = 1 \text{ V, } f = 1 \text{ MHz, } T_j = 25 ^{\circ}\text{C}$		237			
Total capacitance	С	$V_R = 400 \text{ V}, f = 1 \text{ MHz}, T_j = 25 ^{\circ}\text{C}$		25		pF	
•		$V_R = 1000 \text{ V}, f = 1 \text{ MHz}, T_j = 25 ^{\circ}\text{C}$			20		



#### Figures:

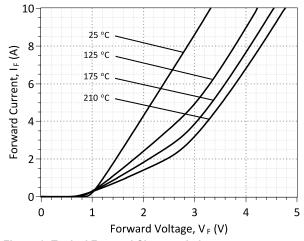


Figure 1: Typical Forward Characteristics

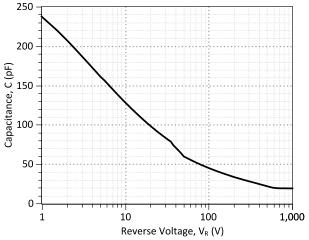


Figure 3: Typical Junction Capacitance vs Reverse Voltage Characteristics

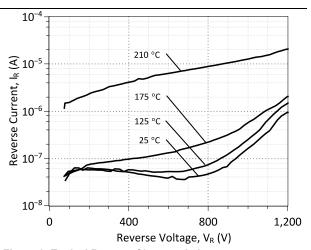


Figure 2: Typical Reverse Characteristics

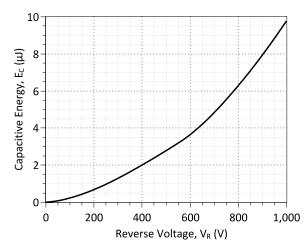


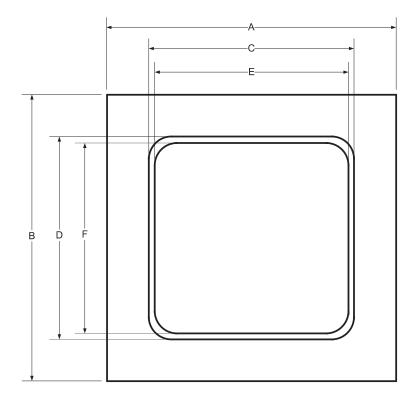
Figure 4: Typical Capacitive Energy vs Reverse Voltage Characteristics



### **Mechanical Parameters**

Die Dimensions	1.6 x 1.6			
Anode pad size	1.34 x 1.34	mm <sup>2</sup>		
Die Area total / active	2.56/1.69			
Die Thickness	360	μm		
Wafer Size	100	mm		
Flat Position	0	deg		
Die Frontside Passivation	Polyimide	Polyimide		
Anode Pad Metallization	4000 nm Al	4000 nm Al		
Backside Cathode Metallization	400 nm Ni + 200 nm Au	400 nm Ni + 200 nm Au		
Die Attach	Electrically conductive glue or	Electrically conductive glue or solder		
Wire Bond	Al ≤ 350 μm	Al ≤ 350 μm		
Reject ink dot size	Φ ≥ 0.3 mm	Φ ≥ 0.3 mm		
December and advances and december and	Store in original container, in dry	Store in original container, in dry nitrogen,		
Recommended storage environment	< 6 months at an ambient temperat	< 6 months at an ambient temperature of 23 °C		

## **Chip Dimensions:**



DIE	A [mm]	1.6
	B [mm]	1.6
METAL	C [mm]	1.34
	D [mm]	1.34
WIRE BONDABLE	E [mm]	1.3
	F [mm]	1.3



## **Die Datasheet**

## GB05SHT12-CAL

Revision History					
Date	Revision	Comments	Supersedes		
2015/02/09	1	Inserted Mechanical Parameters			
2012/04/03	0	Initial release			

Published by GeneSiC Semiconductor, Inc. 43670 Trade Center Place Suite 155 Dulles, VA 20166

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#### **SPICE Model Parameters**

This is a secure document. Please copy this code from the SPICE model PDF file on our website (http://www.genesicsemi.com/images/hit\_sic/baredie/schottky/GB05SHT12-CAL\_SPICE.pdf) into LTSPICE (version 4) software for simulation of the GB05SHT12-CAL.

```
MODEL OF GeneSiC Semiconductor Inc.
     $Revision: 1.0
     $Date: 05-SEP-2013
     GeneSiC Semiconductor Inc.
     43670 Trade Center Place Ste. 155
     Dulles, VA 20166
     COPYRIGHT (C) 2013 GeneSiC Semiconductor Inc.
     ALL RIGHTS RESERVED
* These models are provided "AS IS, WHERE IS, AND WITH NO WARRANTY
* OF ANY KIND EITHER EXPRESSED OR IMPLIED, INCLUDING BUT NOT LIMITED
* TO ANY IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A
* PARTICULAR PURPOSE."
* Models accurate up to 2 times rated drain current.
 Start of GB05SHT12-CAL SPICE Model
.SUBCKT GB05SHT12 ANODE KATHODE
R1 ANODE INT R=((TEMP-24)*0.0021); Temperature Dependant Resistor
D1 INT KATHODE GB05SHT12 25C; Call the 25C Diode Model
D2 ANODE KATHODE GB05SHT12 PIN; Call the PiN Diode Model
.MODEL GB05SHT12 25C D
+ IS
         4.45E-15
                           RS
                                      0.206
          1.18144
                                      112.92
+ N
                           IKF
+ EG
          1.2
                           XTI
+ CJO
          3.00E-10
                           VJ
                                      0.419
+ M
          1.6
                           FC
                                      0.5
+ TT
         1.00E-10
                                      1200
                           BV
+ IBV
          1.00E-03
                           VPK
                                      1200
+ IAVE
                                      SiC Schottky
                           TYPE
          GeneSiC Semiconductor
+ MFG
.MODEL GB05SHT12 PIN D
+ IS
          2.93E-12
                                      0.35326
                           RS
                                      0.0043236
+ N
          4.6113
                           IKF
+ EG
          3.23
                          XTI
                                      60
+ FC
          0.5
                          TT
+ BV
          1200
                           IBV
                                      1.00E-03
+ VPK
          1200
                           IAVE
                                      2.5
+ TYPE
          SiC PiN
.ENDS
```

<sup>\*</sup> End of GB05SHT12-CAL SPICE Model